LOW PHASE-NOISE TWO-CHANNEL CLOCK FAN-OUT BUFFER

Check for Samples: CDC3RL02

FEATURES

- **Low Additive Noise:**
  - **–149 dBc/Hz at 10-kHz Offset Phase Noise**
  - **0.37-ps (RMS) Output Jitter**
- **Limited Output Slew Rate for EMI Reduction (1- to 5-ns/Rise/Fall Time for 10-pF to 50-pF Loads)**
- **Adaptive Output Stage Controls Reflection**
- **Regulated 1.8-V Externally Available I/O Supply**
- **Ultra-Small 8-bump YFP 0.4-mm Pitch WCSP (0.8 mm × 1.6 mm)**
- **EESD Performance Exceeds JESD 22**
  - **2000-V Human-Body Model (A114-A)**
  - **1000-V Charged-Device Model (JESD22-C101-A Level III)**

APPLICATIONS

- **Cellular Phones**
- **Global Positioning Systems (GPS)**
- **Wireless LAN**
- **FM Radio**
- **WiMAX**
- **W-BT**

YFP PACKAGE (TOP VIEW)

Table 1. YFP PACKAGE TERMINAL ASSIGNMENTS

	1	2
A	V_{BATT}	CLK_OUT1
B	V_{LDO}	CLK_REQ1
C	MCLK_IN	CLK_REQ2
D	GND	CLK_OUT2

DESCRIPTION/ORDERING INFORMATION

The CDC3RL02 is a two-channel clock fan-out buffer. It buffers a single master clock, such as a temperature compensated crystal oscillator (TCXO) to multiple peripherals. The device has two clock request inputs (CLK_REQ1 and CLK_REQ2), each of which enable a single clock output.

The CDC3RL02 accepts square or sine waves at the master clock input (MCLK_IN), eliminating the need for an AC coupling capacitor. The smallest acceptable sine wave is a 0.3-V signal (peak-to-peak). CDC3RL02 has been designed to offer minimal channel-to-channel skew, additive output jitter, and additive phase noise. The adaptive clock output buffers offer controlled slew-rate over a wide capacitive loading range which minimizes EMI emissions, maintains signal integrity, and minimizes ringing caused by signal reflections on the clock distribution lines.

The CDC3RL02 has an integrated Low-Drop-Out (LDO) voltage regulator which accepts input voltages from 2.3 V to 5.5 V and outputs 1.8 V, 50 mA. This 1.8V supply is externally available to provide regulated power to peripheral devices such as a TCXO.

The CDC3RL02 is ideal for use in portable end-equipment, such as mobile phones, that require clock buffering with minimal additive phase noise and fan-out capabilities. It is offered in a 0.4-mm pitch wafer-level chip-scale (WCSP) package (0.8 mm × 1.6 mm) and is optimized for very low standby current consumption.

ORDERING INFORMATION

T_A	PACKAGE(1) (2)		ORDERABLE PART NUMBER	TOP-SIDE MARKING(3)
–40°C to 85°C	NanoStar™ WCSP – YFP	Tape and reel	CDC3RL02YFPR	_ _ _ 4 L _

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.
(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.
(3) YFP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the wafer fab/assembly site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, ● = Pb-free).

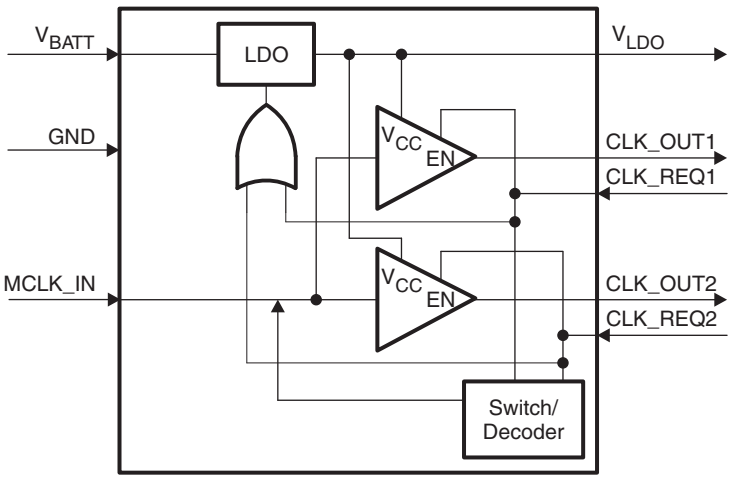
TERMINAL FUNCTIONS

NO.	NAME	I/O	DESCRIPTION
A1	V_{BATT}	I	Input to internal LDO
A2	CLK_OUT1	O	Clock output 1
B1	V_{LDO}	O	1.8 V I/O supply for CDC3RL02 and external TCXO
B2	CLK_REQ1	I	Clock request from peripheral 2
C1	MCLK_IN	I	Master clock input
C2	CLK_REQ2	I	Clock request from peripheral 1
D1	GND	–	Ground
D2	CLK_OUT2	O	Clock output 2

Table 2. FUNCTION TABLE

INPUTS			OUTPUTS	
CLK_REQ1	CLK_REQ2	MCLK_IN	CLK_OUT1	CLK_OUT2
L	L	X	L	L
L	H	CLK	L	CLK
H	L	CLK	CLK	L
H	H	CLK	CLK	CLK

LOGIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
	V_{BATT} voltage range(2)		–0.3	7	V
	Voltage range(3)	CLK_REQ_1/2, MCLK_IN	–0.3	V_{BATT} + 0.3	V
		V_{LDO}, CLK_OUT_1/2(2)	–0.3	V_{BATT} + 0.3	
I_{IK}	Input clamp current at V_{BATT}, CLK_REQ_1/2, and MCLK_IN	V_I < 0		–50	mA
I_O	Continuous output current	CLK_OUT1/2		±20	mA
	Continuous current through GND, V_{BATT}, V_{LDO}			±50	mA
	ESD rating	Human-Body Model		2000	V
		Charged-Device Model		1000	
		Machine Model		200	
T_J	Operating virtual junction temperature		–40	150	°C
T_A	Operating ambient temperature range		–40	85	°C
T_{stg}	Storage temperature range		–55	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
(3) All voltage values are with respect to network ground terminal.

RECOMMENDED OPERATING CONDITIONS(1)

			MIN	MAX	UNIT
V_{BATT}	Input voltage		2.3	5.5	V
V_I	Input voltage	MCLK_IN, CLK_REQ1/2	0	1.89	V
V_O	Output voltage	CLK_OUT1/2	0	1.8	V
V_{IH}	High-level input voltage	CLK_REQ1/2	1.3	1.89	V
V_{IL}	Low-level input voltage	CLK_REQ1/2	0	0.5	V
I_{OH}	High-level output current, DC current		–8		mA
I_{OL}	Low-level output current, DC current			8	mA

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. See the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

ELECTRICAL CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
LDO							
V_{OUT}	LDO output voltage	I_{OUT} = 50 mA		1.71	1.8	1.89	V
C_{LDO}	External load capacitance			1		10	µF
$I_{OUT(SC)}$	Short circuit output current	R_L = 0 Ω			100		mA
$I_{0UT(PK)}$	Peak output current	V_{BATT} = 2.3 V, V_{LDO} = V_{OUT} – 5%				100	mA
PSR	Power supply rejection	V_{BATT} = 2.3V, I_{OUT} = 2 mA,	f_{IN} = 217 Hz and 1 kHz	60			dB
			f_{IN} = 3.25 MHz	40			
t_{su}	LDO startup time	V_{BATT} = 2.3 V , C_{LDO} = 1 µF, CLK_REQ_n to V_{LDO} = 1.71 V			0.2		ms
		V_{BATT} = 5.5 V , C_{LDO} = 10 µF, CLK_REQ_n to V_{LDO} = 1.71 V				1	
Power Consumption							
I_{SB}	Standby current	Device in standby (all $V_{CLK\_REQ\_n}$ = 0 V)			0.2	1	µA
I_{CCS}	Static current consumption	Device active but not switching			0.4	1	mA
I_{OB}	Output buffer average current	f_{IN} = 26 MHz, C_{LOAD} = 50 pF			4.2		mA
C_{PD}	Output power dissipation capacitance	f_{IN} = 26 MHz				44	pF
MCLK_IN Input							
I_I	MCLK_IN, CLK_REQ_1/2 leakage current	V_I = V_{LDO} or GND				1	µA
C_I	MCLK_IN capacitance	f_{IN} = 26 MHz			4.75		pF
R_I	MCLK_IN impedance	f_{IN} = 26 MHz			6		kΩ
f_{IN}	MCLK_IN frequency range			10	26	52	MHz
MCLK_IN LVCMOS Source							
	Additive phase noise	f_{IN} = 26 MHz, t_r/t_f ≤ 1 ns	1-kHz offset		–140		dBc/Hz
			10-kHz offset		–149		
			100-kHz offset		–153		
			1-MHz offset		–148		
	Additive jitter	f_{IN} = 26 MHz, V_{PP} = 0.8 V, BW = 10–5 MHz			0.37		ps (rms)
t_{DL}	MCLK_IN to CLK_OUT_n propagation delay				11		ns
DC_L	Output duty cycle	f_{IN} = 26 MHz, DC_{IN} = 50%		45	50	55	%

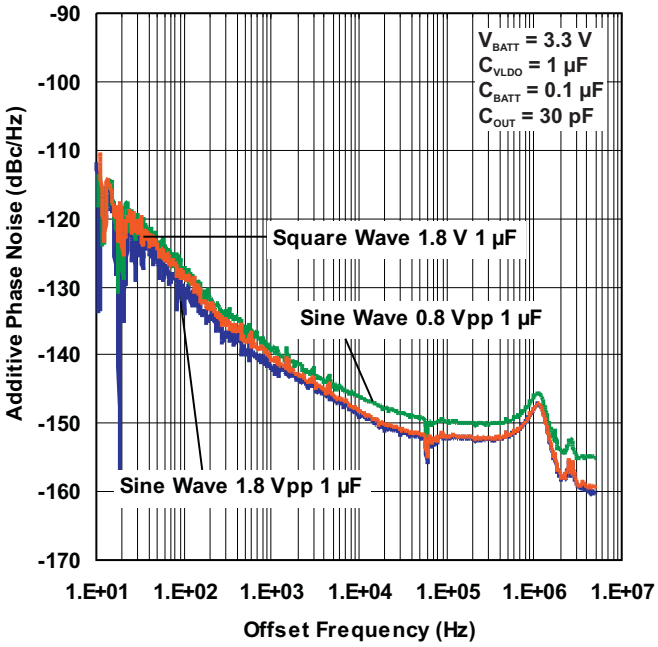
ELECTRICAL CHARACTERISTICS (continued)

over operating free-air temperature range (unless otherwise noted)

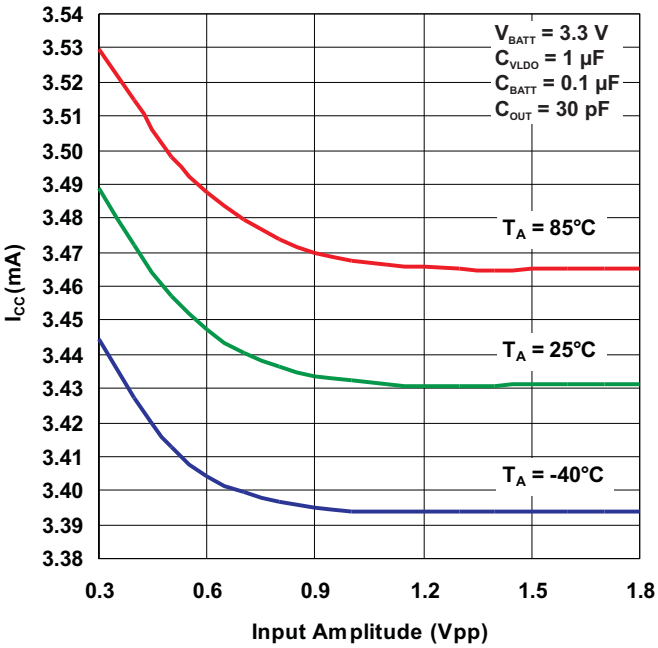
PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
MCLK_IN Sinusoidal Source							
V_{MA}	Input amplitude			0.3		1.8	V
	Additive phase noise	f_{IN} = 26 MHz, V_{MA} = 1.8 V_{PP}	1-kHz offset		–141		dBc/Hz
			10-kHz offset		–149		
			100-kHz offset		–152		
			1-MHz offset		–148		
		f_{IN} = 26 MHz, V_{MA} = 0.8 V_{PP}	1-kHz offset		–139		
			10-kHz offset		–146		
			100-kHz offset		–150		
			1-MHz offset		–146		
	Additive jitter	f_{IN} = 26 MHz, V_{MA} = 1.8 V_{PP}, BW = 10–5 MHz			0.41		ps (RMS)
t_{DS}	MCLK_IN to CLK_OUT_1/2 propagation delay				12		ns
DC_S	Output duty cycle	f_{IN} = 26 MHz, V_{MA} > 1.8 V_{PP}		45	50	55	%
CLK_OUT_N Outputs							
t_r	20% to 80% rise time	C_L = 10 pF to 50 pF		1		5.2	ns
t_f	20% to 80% fall time	C_L = 10 pF to 50 pF		1		5.2	ns
t_{sk}	Channel-to-channel skew	C_L = 10 pF to 50 pF (C_{L1} = C_{L2})		–0.5		0.5	ns
V_{OH}	High-level output voltage	I_{OH} = –100 µA, reference to V_{LDO}		–0.1			V
		I_{OH} = –8 mA		1.2			
V_{OL}	Low-level output voltage	I_{OL} = 20 µA				0.2	V
		I_{OL} = 8 mA				0.55	

TYPICAL PERFORMANCE

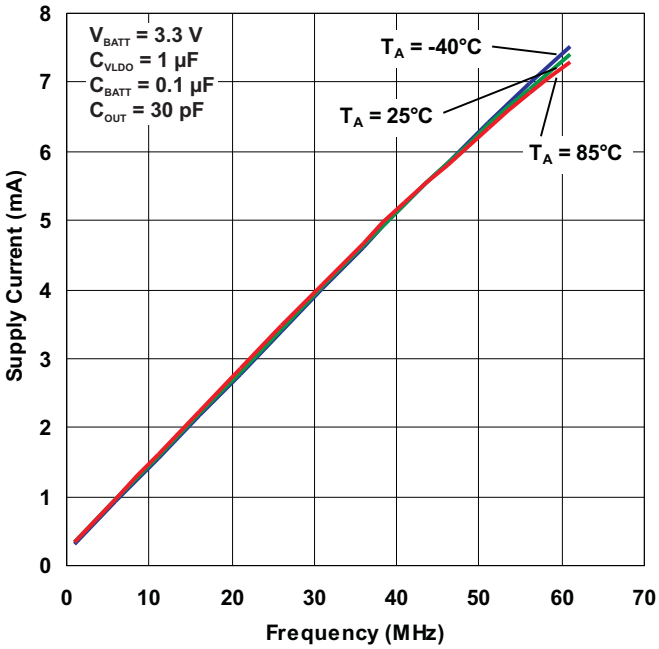
ADDITIVE PHASE NOISE
vs
OFFSET FREQUENCY



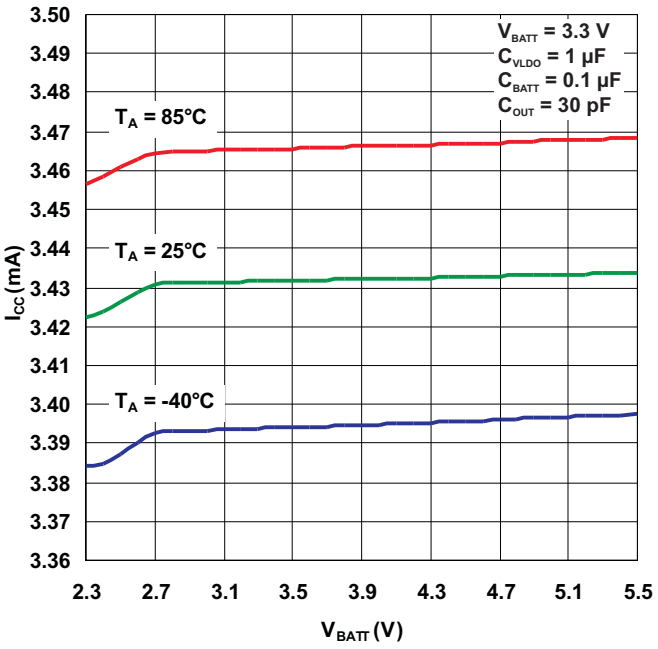
SUPPLY CURRENT
vs
INPUT AMPLITUDE



SUPPLY CURRENT
vs
INPUT FREQUENCY

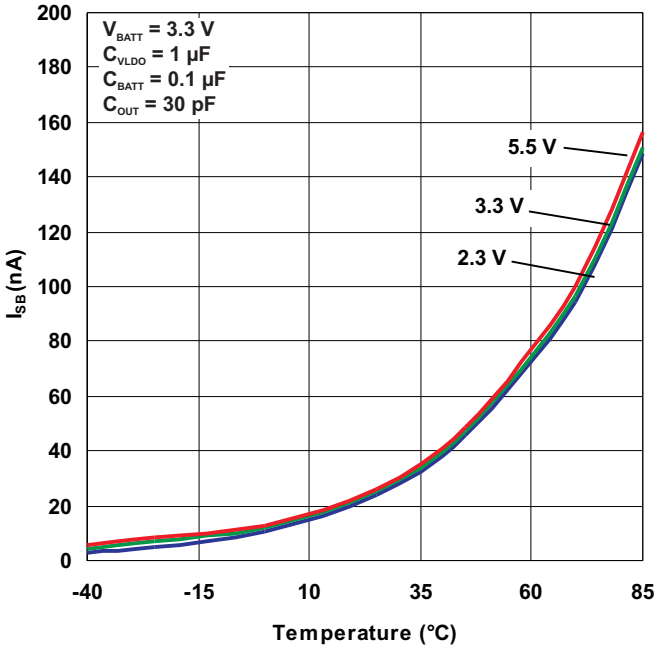


SUPPLY CURRENT
vs
SUPPLY VOLTAGE

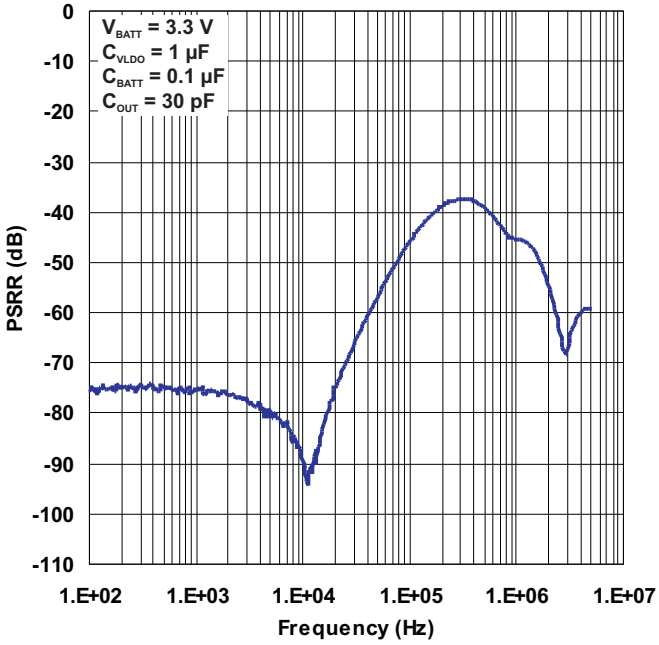


TYPICAL PERFORMANCE (continued)

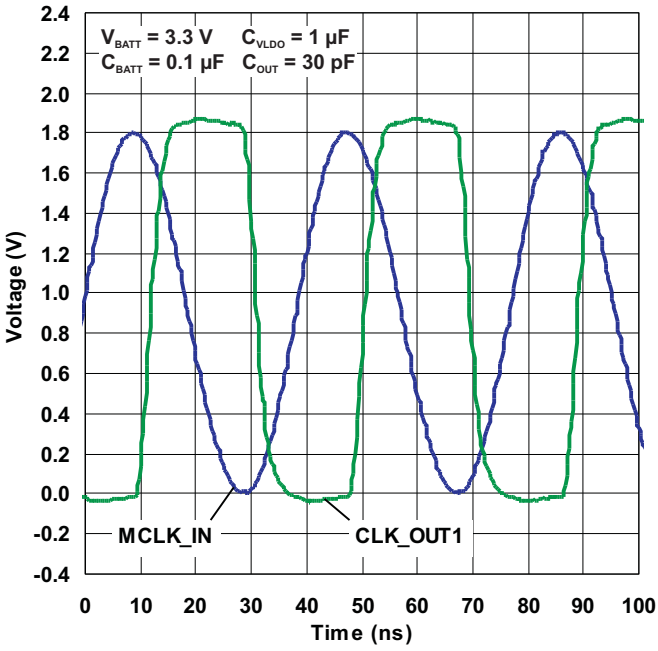
STANDBY CURRENT vs TEMPERATURE



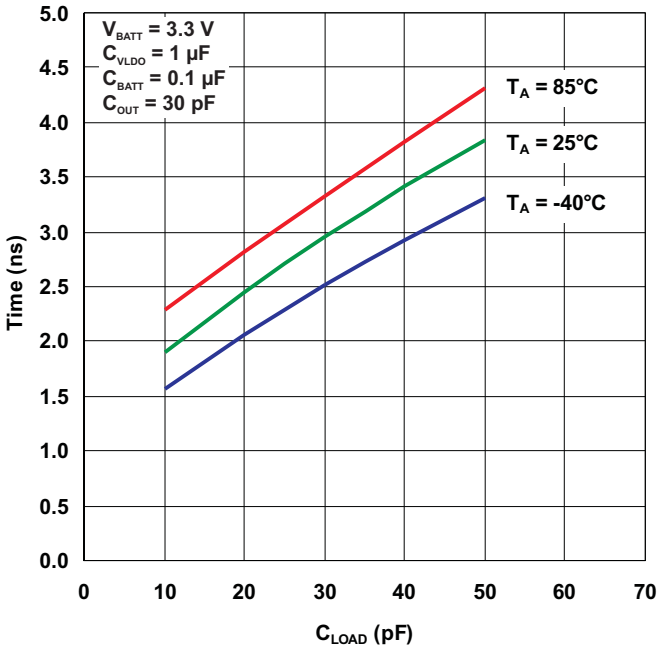
POWER SUPPLY REJECTION vs INPUT FREQUENCY



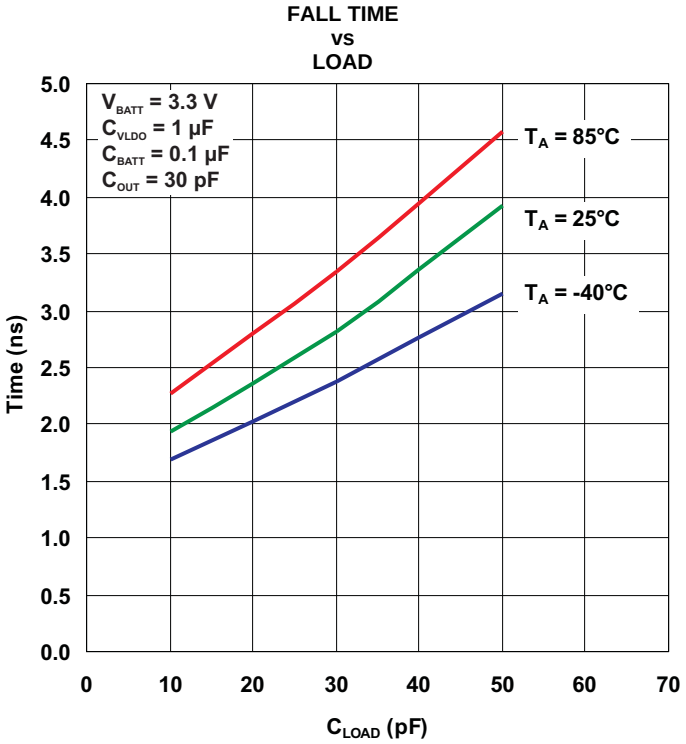
SINE-WAVE INPUT vs SQUARE-WAVE OUTPUT

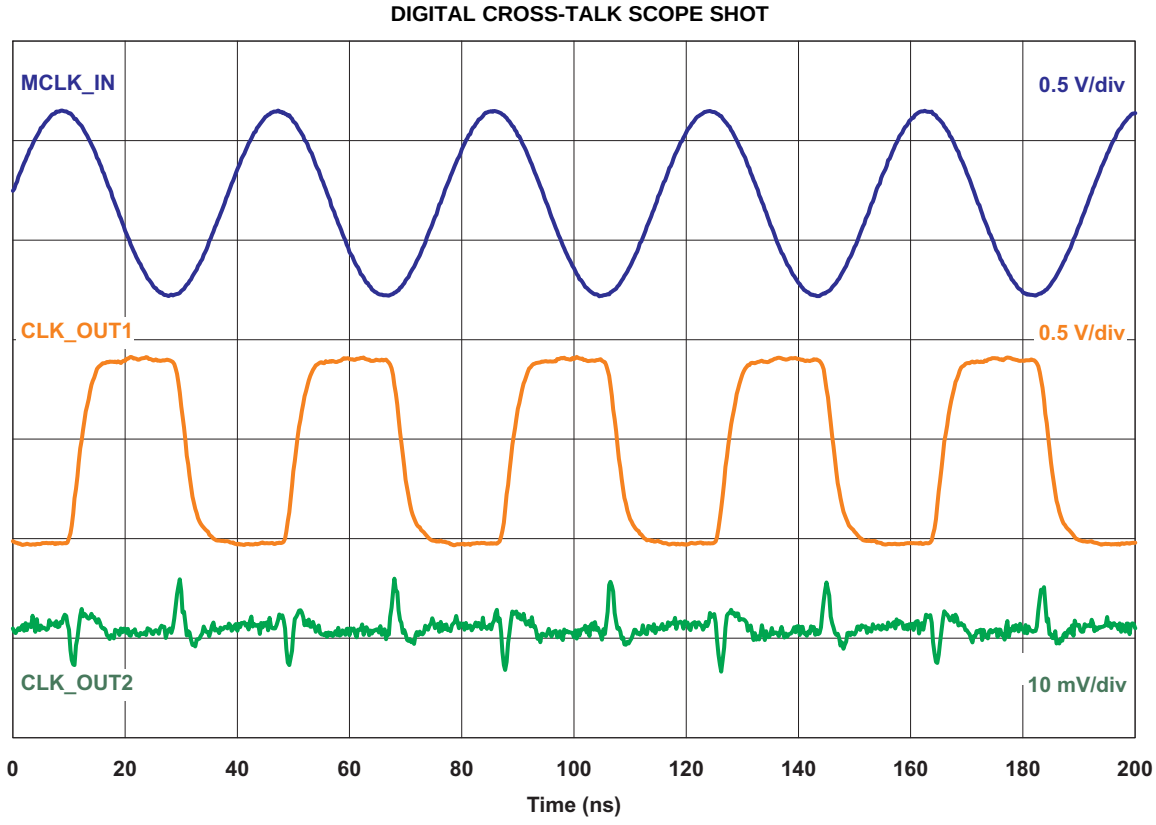


RISE TIME vs LOAD



TYPICAL PERFORMANCE (continued)





APPLICATION INFORMATION

Typical Application

The CDC3RL02 is ideal for use in mobile applications as shown in Figure 1. In this example, a single low noise TCXO system clock source is buffered to drive a mobile GPS receiver and WLAN transceiver. Each peripheral independently requests an active clock by asserting a single clock request line (CLK_REQ_1 or CLK_REQ_2). When both clock request lines are inactive, the CDC3RL02 enters a low current shutdown mode. In this mode, the LDO output, CLK_OUT_1, and CLK_OUT_2 are pulled to GND and the TCXO will be unpowered.

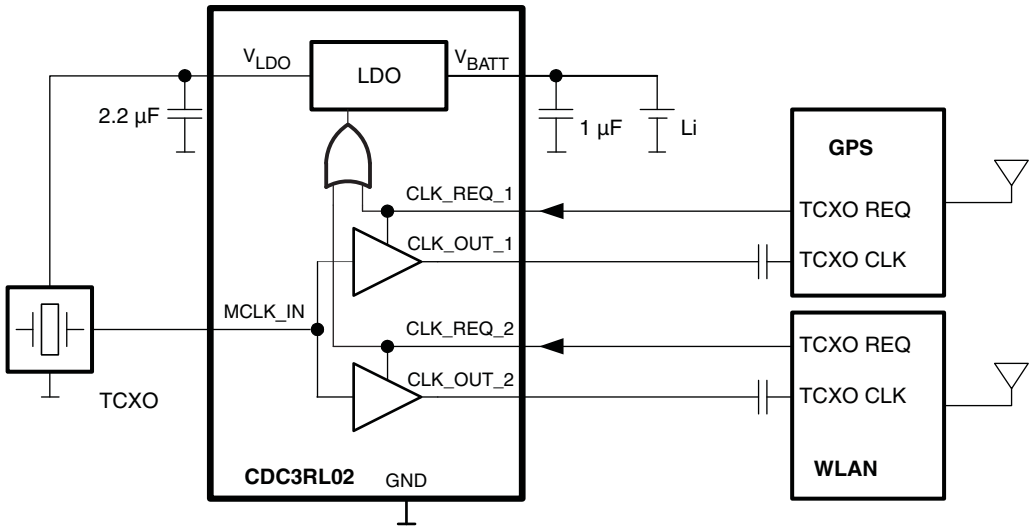


Figure 1. Mobile Application

When either peripheral requests the clock, the CDC3RL02 will enable the LDO and power the TCXO. The TCXO output (square wave, sine wave, or clipped sine wave) is converted to a square wave and buffered to the requested output.

Input Clock Squarer

Figure 2 shows the input stage of the CDC3RL02. The input signal at MCLK_IN can be a square wave or sine wave. CMCLK is an internal AC coupling capacitor that allows a direct connection from the TCXO to the CDC3RL02 without an external capacitor.

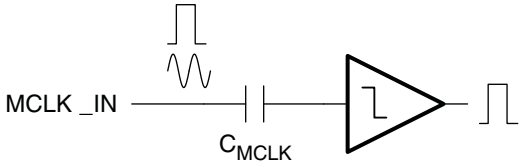


Figure 2. Input Stage

Any external component added in the series path of the clock signal will potentially add phase noise and jitter. The error source associated with the internal decoupling capacitor is included in the specification of the CDC3RL02. The recommended clock frequency band of the CDC3RL02 is 10 MHz to 52 MHz for specified functionality. All performance metrics are specified at 26 MHz. The lowest acceptable sinusoidal signal amplitude is 0.8 V_{PP} for specified performance. Amplitudes as low as 0.3 V_{PP} are acceptable but with reduced phase noise and jitter performance.

Output Stage

Each output drives 1.8-V LVCMOS levels. Adaptive output buffers limit the rise/fall time of the output to within 1 to 5ns with load capacitance between 10 pF and 50 pF. Fast slew rates introduce EMI into the system. Each output buffer limits EMI by keeping the rise/fall time above 1 ns. Slow rise/fall times can induce additive phase noise and duty cycle errors in the load device. The output buffer limits these errors by keeping the rise/fall time below 5 ns. In addition, the output stage dynamically alters impedance based on the instantaneous voltage level of the output. This dynamic change limits reflections keeping the output signal monotonic during transitions. Each output is active low when not requested to avoid false clocking of the load device.

LDO

A low noise 1.8-V LDO is integrated to provide the I/O supply for the output buffers. The LDO output is externally available to power a clock source such as a TCXO. A clean supply is provided to the clock buffers and the clock source for optimum phase noise performance. The input range of the LDO allows the device to be powered directly from a single cell Li battery. The LDO is enabled by either of the CLK_REQ_N signals. When disabled, the device enters a low power shutdown mode consuming less than 1 µA from the battery. The LDO requires an output decoupling capacitor in the range of 1 µF to 10 µF for compensation and high frequency PSR. This capacitor must stay within the specified range over the entire operating temperature range. An input bypass capacitor of 1 µF or larger is recommended.

PACKAGING INFORMATION

Orderable Device	Status [1]	Package Type	Package Drawing	Pins	Package Qty	Eco Plan [2]	Lead/Ball Finish	MSL Peak Temp [3]
CDC3RL02YFPR	ACTIVE	DSBGA	YFP	8	3000	Green (RoHS & no Sb/Br)	Call TI	Level-1-260C-UNLIM

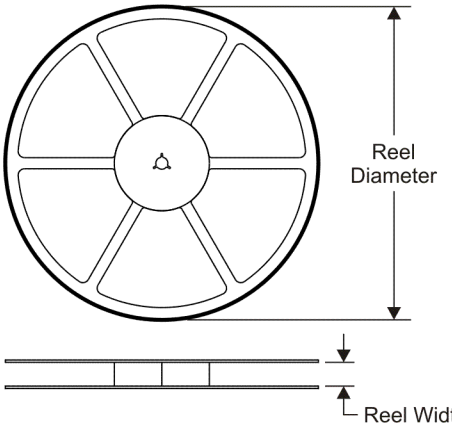
[1] The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

[2] Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

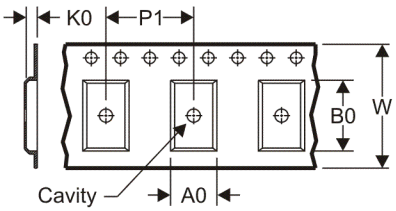
[3] MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

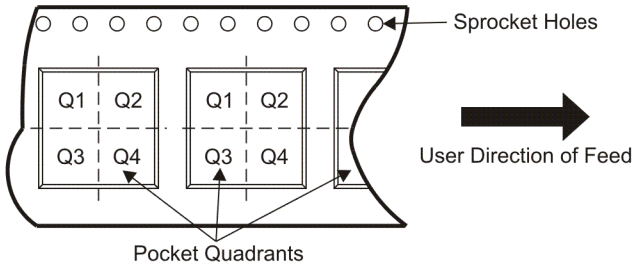


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

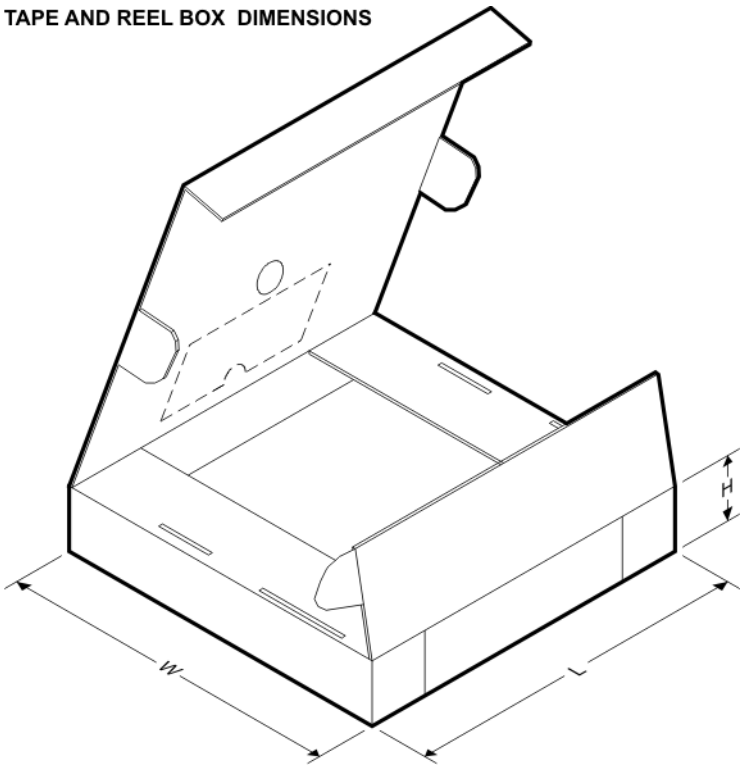
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDC3RL02YFPR	DSBGA	YFP	8	3000	180.0	8.4	0.9	1.75	0.6	4.0	8.0	Q1

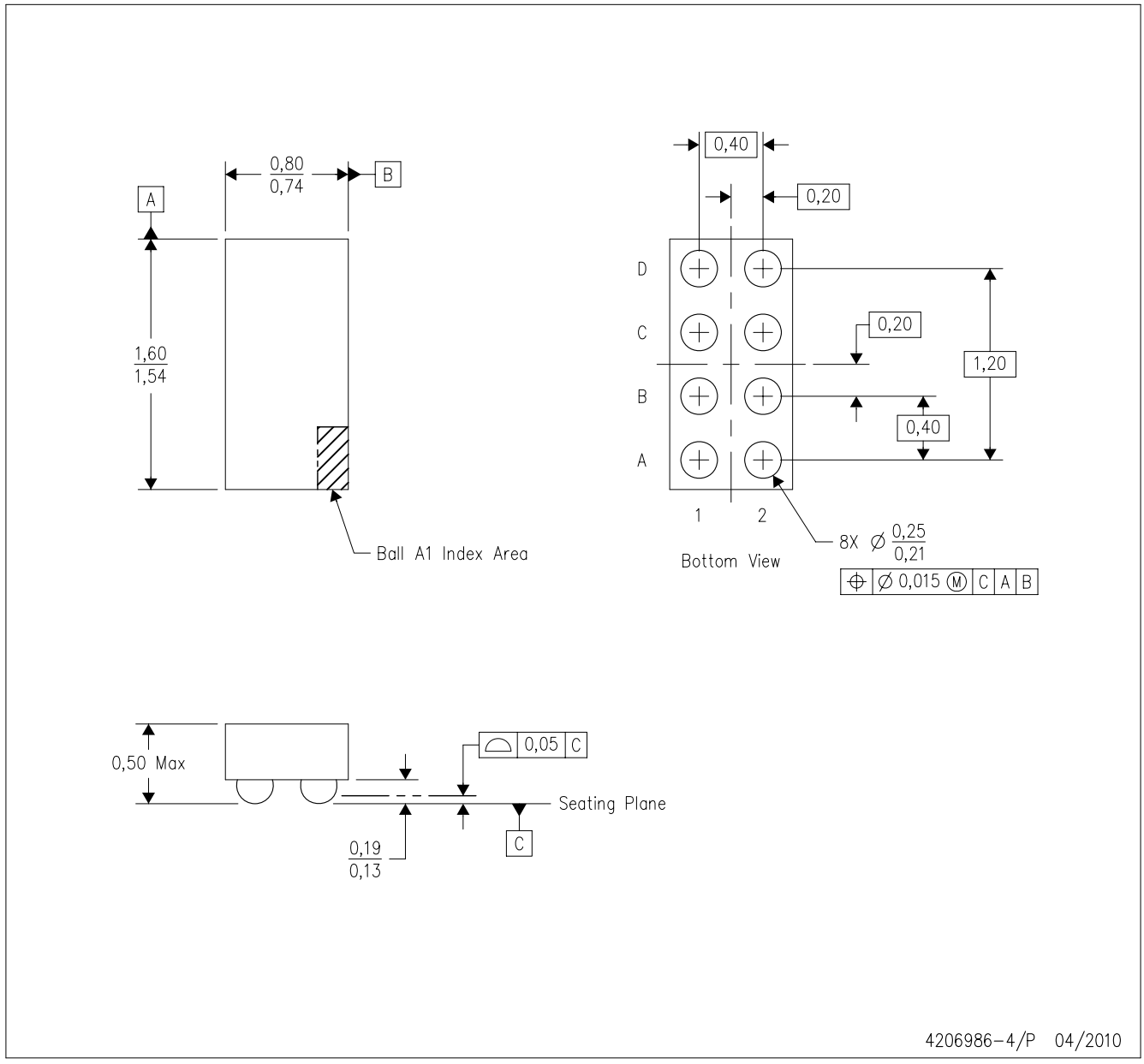
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDC3RL02YFPR	DSBGA	YFP	8	3000	220.0	220.0	34.0

YFP (R–XBGA–N8) DIE–SIZE BALL GRID ARRAY



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NOTES:
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M–1994.
B. This drawing is subject to change without notice.
C. NanoFree™ package configuration.
D. This is a Pb–free solder ball design.

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